TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

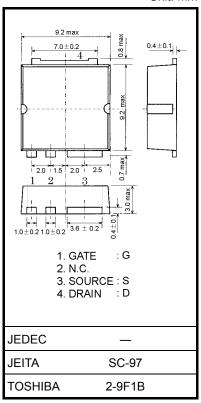
# 2SK3499

Switching Regulator and DC-DC Converter Applications Motor Drive Applications

- Low drain-source ON resistance:  $RDS(ON) = 0.4 \Omega$  (typ.)
- High forward transfer admittance:  $|\,Y_{\rm fs}\,|$  = 8.0 S (typ.)
- Low leakage current:  $I_{DSS}$  = 100  $\mu A$  (max) (V\_{DS} = 400 V)
- Enhancement model:  $V_{th}$  = 2.0 to 4.0 V ( $V_{DS}$  = 10 V,  $I_D$  = 1 mA)

# Absolute Maximum Ratings (Ta = 25°C)

| Characteristics                                      |                | Symbol           | Rating    | Unit |  |
|--|----------------|------------------|-----------|------|--|
| Drain-source voltage                                 |                | V <sub>DSS</sub> | 400       | V    |  |
| Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ ) |                | V <sub>DGR</sub> | 400       | V    |  |
| Gate-source voltage                                  |                | V <sub>GSS</sub> | ±30       | V    |  |
| Drain current  | DC (Note 1)    | ۱ <sub>D</sub>   | 10        | А    |  |
|  | Pulse (Note 1) | I <sub>DP</sub>  | 40        | A    |  |
| Drain power dissipation (Tc = $25^{\circ}$ C)        |                | PD               | 80        | W    |  |
| Single pulse avalanche energy<br>(Note 2)            |                | E <sub>AS</sub>  | 360       | mJ   |  |
| Avalanche current                                    |                | I <sub>AR</sub>  | 10        | А    |  |
| Repetitive avalanche energy (Note 3)                 |                | E <sub>AR</sub>  | 8         | mJ   |  |
| Channel temperature                                  |                | T <sub>ch</sub>  | 150       | °C   |  |
| Storage temperature range                            |                | T <sub>stg</sub> | -55 to150 | °C   |  |



Weight: 0.74 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

## **Thermal Characteristics**

| Characteristics                     | Symbol                 | Max  | Unit |  |
|-------------------------------------|------------------------|------|------|--|
| Thermal resistance, channel to case | R <sub>th (ch-c)</sub> | 1.56 | °C/W |  |

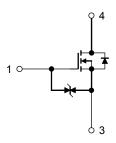
Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD} = 90 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$  (initial), L = 5.85 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AR</sub> = 10 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

## **Circuit Configuration**



Unit: mm

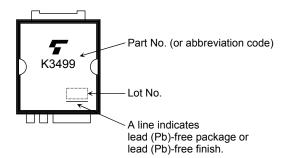
**Electrical Characteristics (Ta = 25°C)** 

| Char   | acteristics    | Symbol               | Test Condition  | Min | Тур. | Max  | Unit |
|--|----------------|----------------------|---|-----|------|------|------|
| Gate leakage current                               |                | I <sub>GSS</sub>     | $V_{GS}=\pm 25~V,~V_{DS}=0~V$   |     |      | ±10  | μA   |
| Drain-source breakdown voltage                     |                | V (BR) GSS           | $I_G=\pm 10~\mu A,~V_{DS}=0~V$  | ±30 | —    | _    | V    |
| Drain cut-OFF current                              |                | I <sub>DSS</sub>     | $V_{DS} = 400 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$  | —   | —    | 100  | μA   |
| Drain-source bre                                   | akdown voltage | V (BR) DSS           | $I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$   | 400 |      | _    | V    |
| Gate threshold voltage                             |                | V <sub>th</sub>      | $V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$   | 2.0 |      | 4.0  | V    |
| Drain-source ON                                    | resistance     | R <sub>DS (ON)</sub> | $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 5.0 \text{ A}$  | _   | 4.0  | 0.55 | Ω    |
| Forward transfer admittance                        |                | Y <sub>fs</sub>      | $V_{DS} = 10 \text{ V}, \text{ I}_{D} = 5.0 \text{ A}$  | 4.0 | 0.8  | _    | S    |
| Input capacitance                                  |                | C <sub>iss</sub>     |   | —   | 1340 | _    | pF   |
| Reverse transfer capacitance                       |                | C <sub>rss</sub>     | $V_{DS} = 10 \text{ V},  V_{GS} = 0 \text{ V},  \text{f} = 1  \text{MHz}$                                   | —   | 160  | _    |      |
| Output capacitance                                 |                | C <sub>oss</sub>     |   | —   | 490  | _    |      |
| Switching time                                     | Rise time      | tr                   | $V_{GS}^{10 V} \downarrow_{DD} = 5 \text{ A} \\ V_{GS}^{C} \downarrow_{DV} \downarrow_{DD} = 200 \text{ V}$ | _   | 22   |      | ns   |
|  | Turn-ON time   | t <sub>on</sub>      |   | _   | 60   |      |      |
|  | Fall time      | t <sub>f</sub>       |   | _   | 32   | _    |      |
|  | Turn-OFF time  | t <sub>off</sub>     |   | _   | 140  |      |      |
| Total gate charge<br>(gate-source plus gate-drain) |                | Qg                   |   |     | 34   | _    | nC   |
| Gate-source charge                                 |                | Q <sub>gs</sub>      | $V_{DD} \simeq 320 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 10 \text{ A}$                  | —   | 18   | _    |      |
| Gate-drain ("miller") charge                       |                | Q <sub>gd</sub>      |   | _   | 16   |      |      |

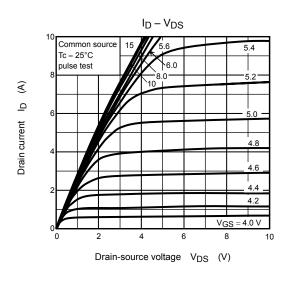
# Source-Drain Ratings and Characteristics (Ta = 25°C)

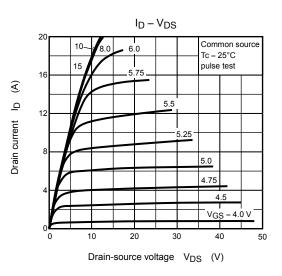
| Characteristics                           | Symbol           | Test Condition                                 | Min | Тур. | Max  | Unit |
|---|------------------|--|-----|------|------|------|
| Continuous drain reverse current (Note 1) | I <sub>DR</sub>  | —  | _   | _    | 10   | А    |
| Pulse drain reverse current (Note 1)      | I <sub>DRP</sub> | —  | _   | _    | 40   | А    |
| Forward voltage (diode)                   | V <sub>DSF</sub> | I <sub>DR</sub> = 10 A, V <sub>GS</sub> = 0 V  | _   | _    | -1.7 | V    |
| Reverse recovery time                     | t <sub>rr</sub>  | $I_{DR} = 10 \text{ A}, V_{GS} = 0 \text{ V},$ | _   | 350  | _    | μS   |
| Reverse recovery charge                   | Q <sub>rr</sub>  | dl <sub>DR</sub> /dt = 100 A/μs                | _   | 3.6  | _    | μC   |

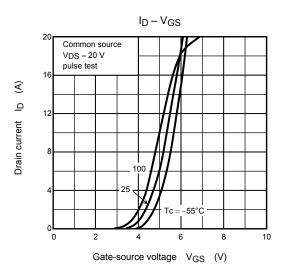
## Marking

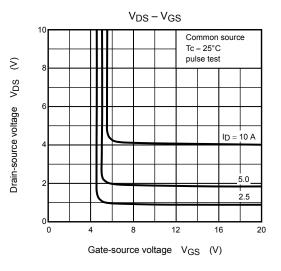


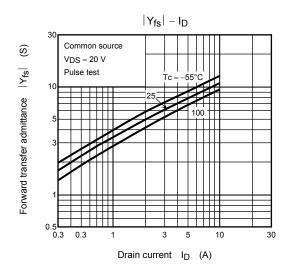
# **TOSHIBA**



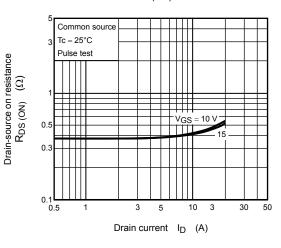




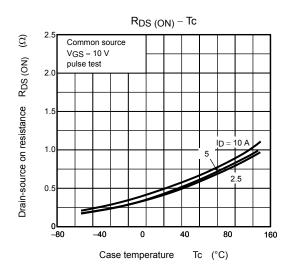


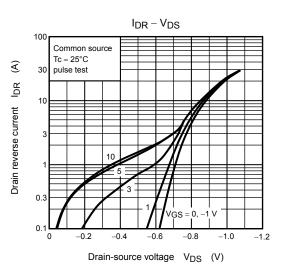


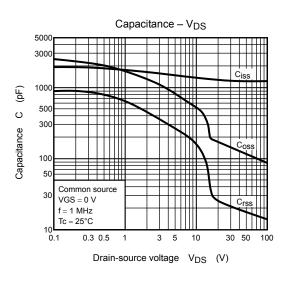
R<sub>DS (ON)</sub> – I<sub>D</sub>

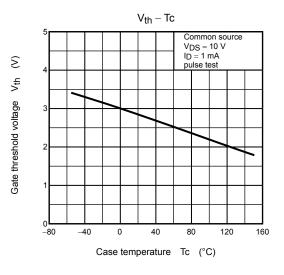


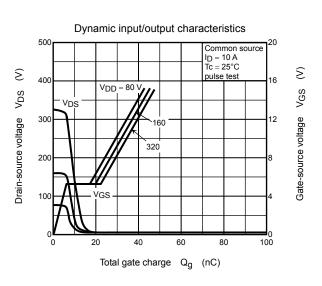
# TOSHIBA

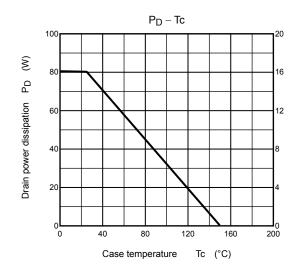


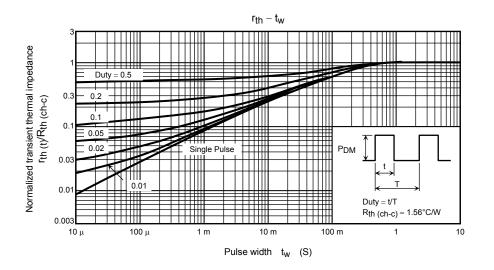




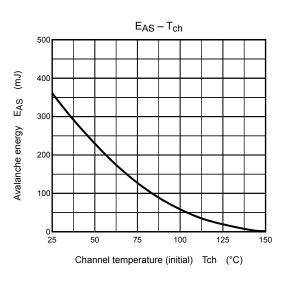


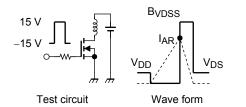


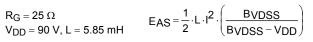




Safe operating area 100 (pulsed) \* 50 In ma 30 00 ID ma (continuous) 10 E Drain current I<sub>D</sub> DC operation 0.5 0.3 0.1 Single nonrepetitive pulse 0.05  $Tc = 25^{\circ}C$ V<sub>DSS</sub> ma 0.03 Curves must be derated linearly with increase in temperature. 0.01 10 100 1000 1 Drain-source voltage V<sub>DS</sub> (V)







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